

## STS9NF30L

# N-CHANNEL 30V - 0.015 $\Omega$ - 9A SO-8 LOW GATE CHARGE STripFET<sup>TM</sup> II POWER MOSFET

TYPE	V <sub>DSS</sub>	R <sub>DS(on)</sub>	ΙD
STS9NF30L	30 V	<0.020 Ω	9 A

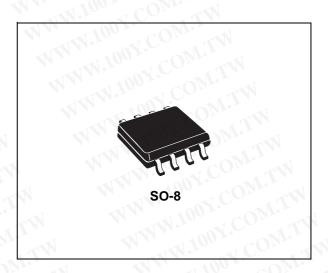
- TYPICAL R<sub>DS</sub>(on) = 0.020 Ω @ 5 V
- TYPICAL Qg = 9.5 nC @ 4.5 V
- OPTIMAL R<sub>DS</sub>(on) x Qg TRADE-OFF
- CONDUCTION LOSSES REDUCED
- SWITCHING LOSSES REDUCED

#### **DESCRIPTION**

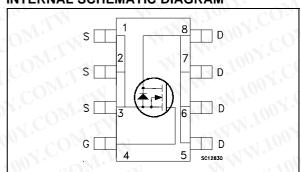
This application specific Power MOSFET is the second generation of STMicroelectronis unique "Single Feature Size<sup>TM</sup>" strip-based process. The resulting transistor shows the best trade-off between on-resistance and gate charge. When used as high and low side in buck regulators, it gives the best performance in terms of both conduction and switching losses. This is extremely important for motherboards where fast switching and high efficiency are of paramount importance.

#### **APPLICATIONS**

 SPECIFICALLY DESIGNED AND OPTIMISED FOR HIGH EFFICIENCY CPU CORE DC/DC CONVERTERS FOR MOBILE PCS



## INTERNAL SCHEMATIC DIAGRAM



#### **ABSOLUTE MAXIMUM RATINGS**

Symbol	Parameter	Value	Unit
V <sub>DS</sub>	Drain-source Voltage (V <sub>GS</sub> = 0)	30	V
$V_{DGR}$	Drain-gate Voltage ( $R_{GS} = 20 \text{ k}\Omega$ )	30	V
$V_{GS}$	Gate- source Voltage	± 18	V
I <sub>D</sub>	Drain Current (continuous) at T <sub>C</sub> = 25°C	9	Α
I <sub>D</sub>	Drain Current (continuous) at T <sub>C</sub> = 100°C	5.7	Α
I <sub>DM</sub> (•)	Drain Current (pulsed)	36	Α
P <sub>tot</sub>	Total Dissipation at T <sub>C</sub> = 25°C	2.5	W

(•) Pulse width limited by safe operating area.

December 2002

#### THERMAL DATA

Rthj-amb	(*)Thermal Resistance Junction-ambient Max	50	°C/W
Tj	Maximum Operating Junction Temperature	150	°C
T <sub>stg</sub>	Storage Temperature	-55 to 150	°C

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# **ELECTRICAL CHARACTERISTICS** (T<sub>case</sub> = 25 °C unless otherwise specified) OFF

## OFF

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source Breakdown Voltage	I <sub>D</sub> = 250 μA, V <sub>GS</sub> = 0	30		TW	V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current (V <sub>GS</sub> = 0)	$V_{DS}$ = Max Rating $V_{DS}$ = Max Rating $T_{C}$ = 125°C	W.100	N.CO	1 10	μA μA
I <sub>GSS</sub>	Gate-body Leakage Current (V <sub>DS</sub> = 0)	V <sub>GS</sub> = ± 18 V	MM	007.C	±100	nA

	carrette (*DS = e)	J CO' TI				$\mathbb{C}_{\mathcal{O}_{r}}$	
ON (*)							
Symbol	Parameter	Test Co	onditions	Min.	Тур.	Max.	Unit
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}$	I <sub>D</sub> = 250 μA	1	W.10	-1 C	V
R <sub>DS(on)</sub>	Static Drain-source On Resistance	V <sub>GS</sub> = 10 V V <sub>GS</sub> = 5 V	I <sub>D</sub> = 4.5 A I <sub>D</sub> = 4.5 A	W	0.015 0.020	0.020 0.035	$\Omega$ $\Omega$
41 CO23		11 1 CC			-11	300	CON

Symbol gfs (*)	Parameter Forward Transconductance	Test Conditions $V_{DS}=15 \text{ V} \qquad I_{D}=4.5 \text{ A}$	Min.	<b>Typ.</b> 13	Max.	Unit
C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub>	Input Capacitance Output Capacitance Reverse Transfer Capacitance	V <sub>DS</sub> = 25V, f = 1 MHz, V <sub>GS</sub> = 0	TH	730 265 60	NAM	pF pF pF

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<sup>(\*)</sup> When mounted on FR-4 board with 0.5 in<sup>2</sup> pad of Cu.

#### **ELECTRICAL CHARACTERISTICS** (continued)

#### SWITCHING ON

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Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
t <sub>d(on)</sub> t <sub>r</sub>	Turn-on Delay Time Rise Time	$\begin{aligned} &V_{DD} = 15\;V & I_{D} = 4.5\;A \\ &R_{G} = 4.7\;\Omega & V_{GS} = 4.5\;V \\ &(Resistive\;Load,\;Figure\;1) \end{aligned}$	Y.COJ	15 80	s.T	ns ns
Q <sub>g</sub> Q <sub>gs</sub> Q <sub>gd</sub>	Total Gate Charge Gate-Source Charge Gate-Drain Charge	V <sub>DD</sub> = 24 V I <sub>D</sub> = 9 A V <sub>GS</sub> = 4.5 V (see test circuit, Figure 2)	ON.C	9.5 3 4	12.5	nC nC nC

#### **SWITCHING OFF**

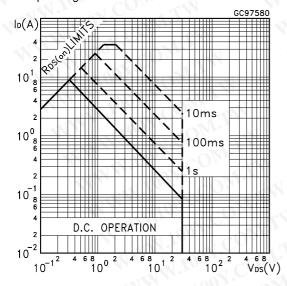
Symbol	Parameter	Test Co	Test Conditions		Тур.	Max.	Unit	
t <sub>d(off)</sub>	Turn-off Delay Time	$V_{DD} = 15 \text{ V}$ $R_G = 4.7\Omega$	I <sub>D</sub> = 4.5 A V <sub>GS</sub> = 4.5 V	10.10	38 24	$O_{M',r}$	ns ns	
1. 1	11/1/1/1007	(Resistive Load			001.	COM.		

#### SOURCE DRAIN DIODE

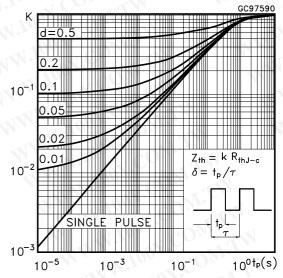
I <sub>SDM</sub> (•)	Source-drain Current Source-drain Current (pulsed)	W.COM.TW	W.10	9 36	A A
V <sub>SD</sub> (*)	Forward On Voltage	I <sub>SD</sub> = 9 A V <sub>GS</sub> = 0	WW.	1.5	V
t <sub>rr</sub> Q <sub>rr</sub> I <sub>RRM</sub>	Reverse Recovery Time Reverse Recovery Charge Reverse Recovery Current	$I_{SD} = 9 \text{ A}$	38 30 1.6	N.1001	ns nC A

<sup>(\*)</sup>Pulsed: Pulse duration = 300 µs, duty cycle 1.5 %.

#### Safe Operating Area



#### Thermal Impedance

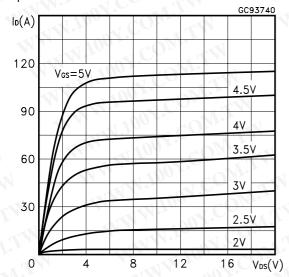


M.M.M. 100 X.C

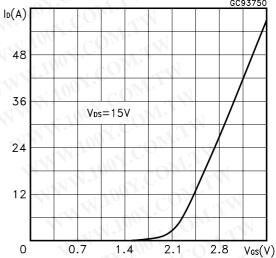
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<sup>(•)</sup>Pulse width limited by safe operating area.

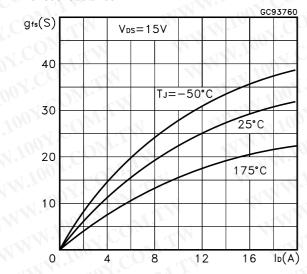
#### **Output Characteristics**



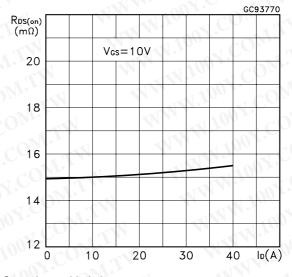
## Transfer Characteristics



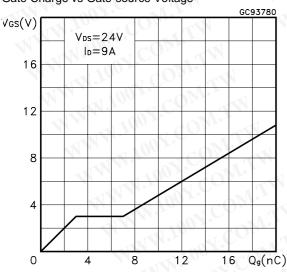
#### Transconductance



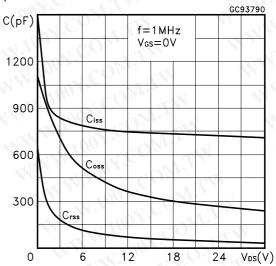
Static Drain-source On Resistance



#### Gate Charge vs Gate-source Voltage



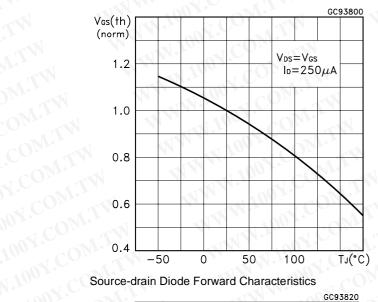
Capacitance Variations

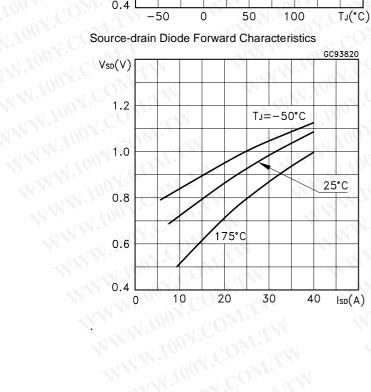


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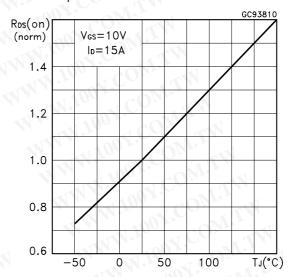
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#### Normalized Gate Threshold Voltage vs Temperature

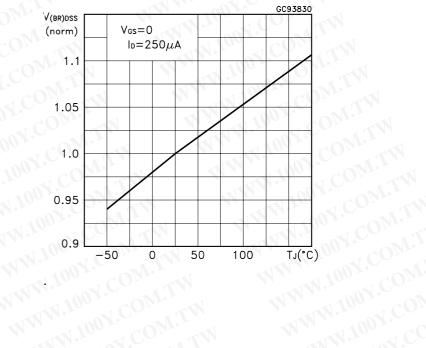




#### Thermal Impedance



#### Normalized Breakdown Voltage Temperature.



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Fig. 1: Switching Times Test Circuits For Resistive

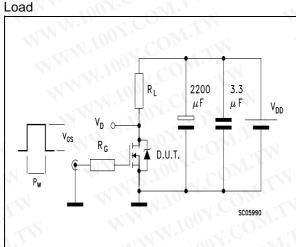
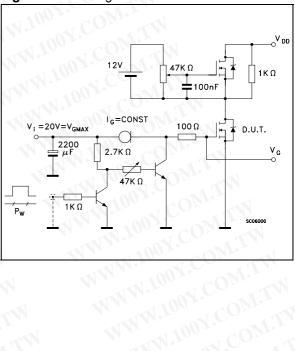
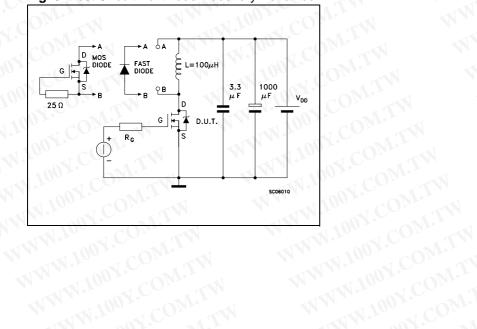


Fig. 2: Gate Charge test Circuit



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Fig. 3: Test Circuit For Diode Recovery Behaviour

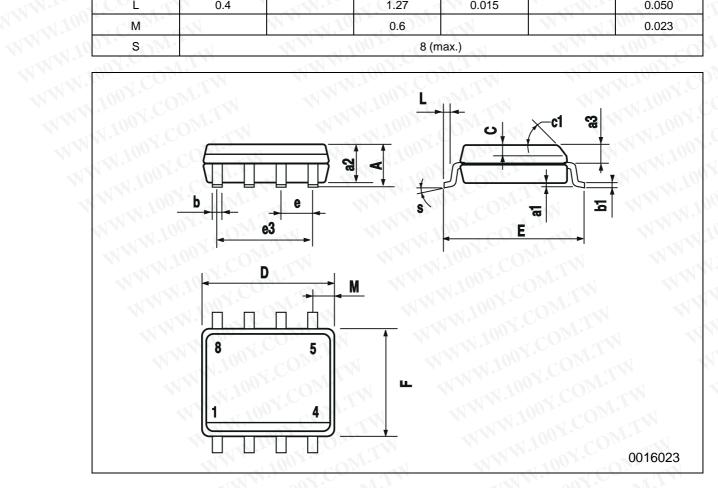


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### **SO-8 MECHANICAL DATA**

DIM.	mm			inch			
Dilvi.	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.	
Α	1007	OM	1.75	1007.	COM	0.068	
a1	0.1		0.25	0.003		0.009	
a2			1.65	WW.	I.Co.	0.064	
а3	0.65	J.CO	0.85	0.025	S.CO.	0.033	
b	0.35	COBI	0.48	0.013	0 -1 COM.	0.018	
b1	0.19	$a_{0,i}$ . $a_{0,i}$	0.25	0.007	001.	0.010	
С	0.25	1001	0.5	0.010	1001	0.019	
c1		· Louy.Co	45	(typ.)	N. T. CO	M.T.N	
D	4.8	J. Joseph Cr	5.0	0.188	N.Jos V.C.	0.196	
E	5.8	131.100	6.2	0.228	151.100	0.244	
е		1.27	-ONL		0.050	COM.	
e3		3.81	·		0.150		
F	3.8	NW.	4.0	0.14		0.157	
COLL	0.4	M. To.	1.27	0.015	M. In. In.	0.050	
M		M. M. 70	0.6		W.	0.023	
S	-55	WW	8 (r	max.)	WW	1007.	



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